

ELECTRICAL CHARACTERISTICS ($T_A=25^\circ\text{C}$ unless otherwise specified)

PARAMETER	SYMBO	MIN	TYP	MAX	UNIT	TEST CONDITIONS
Static						
Gate-Threshold Voltage	$V_{GS(\text{th})}$	1	-	-	V	$V_{DS} = V_{GS}$, $I_D = 250\mu\text{A}$
Gate-Body Leakage	I_{GSS}	-	-	± 100	nA	$V_{DS} = 0\text{V}$, $V_{GS} = 20\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	1	μA	$V_{DS} = 32\text{V}$, $V_{GS} = 0\text{V}$
		-	-	25		$V_{DS} = 32\text{V}$, $V_{GS} = 0\text{V}$, $T_J = 55^\circ\text{C}$
On-State Drain Current ^A	$I_{D(\text{ON})}$	34	-	-	A	$V_{DS} = 5\text{V}$, $V_{GS} = 10\text{V}$
Drain-Source On-Resistance ^A	$R_{DS(\text{ON})}$	-	-	15	$\text{m}\Omega$	$V_{GS} = 10\text{V}$, $I_D = 7.5\text{A}$
		-	-	18		$V_{GS} = 4.5\text{V}$, $I_D = 7\text{A}$
Forward Transconductance ^A	g_{FS}	-	22	-	S	$V_{DS} = 15\text{V}$, $I_D = 7.5\text{A}$
Diode Forward Voltage	V_{SD}	-	1.1	-	V	$I_S = 2.1\text{A}$, $V_{GS} = 0\text{V}$
Dynamic ^b						
Total Gate Charge	Q_g	-	4.0	-	nC	$I_D = 7.5\text{A}$
Gate-Source Charge	Q_{gs}	-	1.1	-		$V_{DS} = 15\text{V}$
Gate-Drain Charge	Q_{gd}	-	1.4	-		$V_{GS} = 4.5\text{V}$
Turn-On Delay Time	$T_{d(\text{ON})}$	-	16	-	nS	$I_D = 34\text{A}$, $V_{DD} = 25\text{V}$
Rise Time	T_r	-	5	-		$V_{GEN} = 10\text{V}$
Turn-Off Delay Time	$T_{d(\text{OFF})}$	-	23	-		$R_L = 25\Omega$
Fall Time	T_f	-	3	-		

Notes

- a. Pulse test : $PW \leq 300\text{ us}$ duty cycle $\leq 2\%$.
- b. Guaranteed by design, not subject to production testing.